

Notice of References Cited	Application/Control No. 10/772,625		Applicant(s)/Patent Under Reexamination OWEN ET AL.	
	Examiner FARHAN M. SYED		Art Unit 2165	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,327,594 B1	12-2001	Van Huben et al.	707/200
*	B	US-2002/0174097 A1	11-2002	Rusch et al.	707/1
*	C	US-2004/0024812 A1	02-2004	Park et al.	709/203
*	D	US-2004/0167880 A1	08-2004	Smith, Gregory	707/003
*	E	US-2004/0167867 A1	08-2004	Owen et al.	707/001
*	F	US-6,985,905 B2	01-2006	Prompt et al.	707/102
*	G	US-7,020,641 B2	03-2006	Leong et al.	706/12
*	H	US-7,058,958 B1	06-2006	Shutt et al.	719/328
*	I	US-2001/0034733	10-2001	Prompt et al.	707/102
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.